

Korean International Semiconductor Conference & Exhibition on Manufacturing Technology 2025

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Re:Innovation of Semiconductor Manufacturing for AI Ecosystem



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Dr. Taeyong Jo is in charge of developing next-generation inspection and measurement technologies at Samsung Electronics Semiconductor. Since joining Samsung Electronics in 2013, he has actively contributed to the development of new inspection and measurement technologies for process control. He received his bachelor's, master's, and doctoral degrees in mechanical engineering from Seoul National University.